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THz Electronic Components and Devices

Guest Editors:

Prof. Dr. Xiaodong Chen

Prof. Dr. Alan Phelps

Prof. Dr. Guoqing Luo

Deadline for manuscript submissions:

closed (31 May 2020)

Message from the Guest Editors

Dear Colleagues,

Following the UCMMT 2019 conference, "The 12th UK/Europe–China Workshop on Millimeter-Waves and Terahertz Technologies" held in London, United Kingdom, on 20–22 August 2019, the authors of papers that were presented on the topics listed below at UCMMT 2019 are now invited to submit their extended versions to this Special Issue. Submitted papers should be extended to the size of regular research or review articles, with at least a 50% extension of new results.

The Special Issue on "THz Electronic Components and Devices" is intended to include a wide range of THz and mm-wave electronic components, diode detectors and mixers, THz and mm-wave solid state electronic components and sources including Si, GaAs, InGaAS, AlAs and GaN materials, modulators, THz and mm-wave vacuum electronic sources, e.g., TWTs, klystrons, EIOs, and gyrotrons.











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Editor-in-Chief

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Message from the Editor-in-Chief

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